## Notice of References Cited Application/Control No. 09/650,375 Examiner Son P. Huynh Applicant(s)/Patent Under Reexamination WONG ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,076,152	07-2006	Eguchi et al.	386/83
*	В	US-7,032,030	04-2006	Codignotto, John David	709/246
*	C	US-2005/0091493	04-2005	Hirata, Shinichi	713/170
*	D	US-6,816,904	11-2004	Ludwig et al.	709/226
*	E	US-6,442,755	08-2002	Lemmons et al.	725/47
*	F	US-2005/0251827	11-2005	Ellis et al.	725/047
*	G	US-2006/0190966	08-2006	McKissick et al.	725/061
*	Τ	US-7,185,355	02-2007	Ellis et al.	725/46
*		US-7,165,098	01-2007	Boyer et al.	709/219
	7	US-			
	K	US-			
	4	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P			<u> </u>		
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.